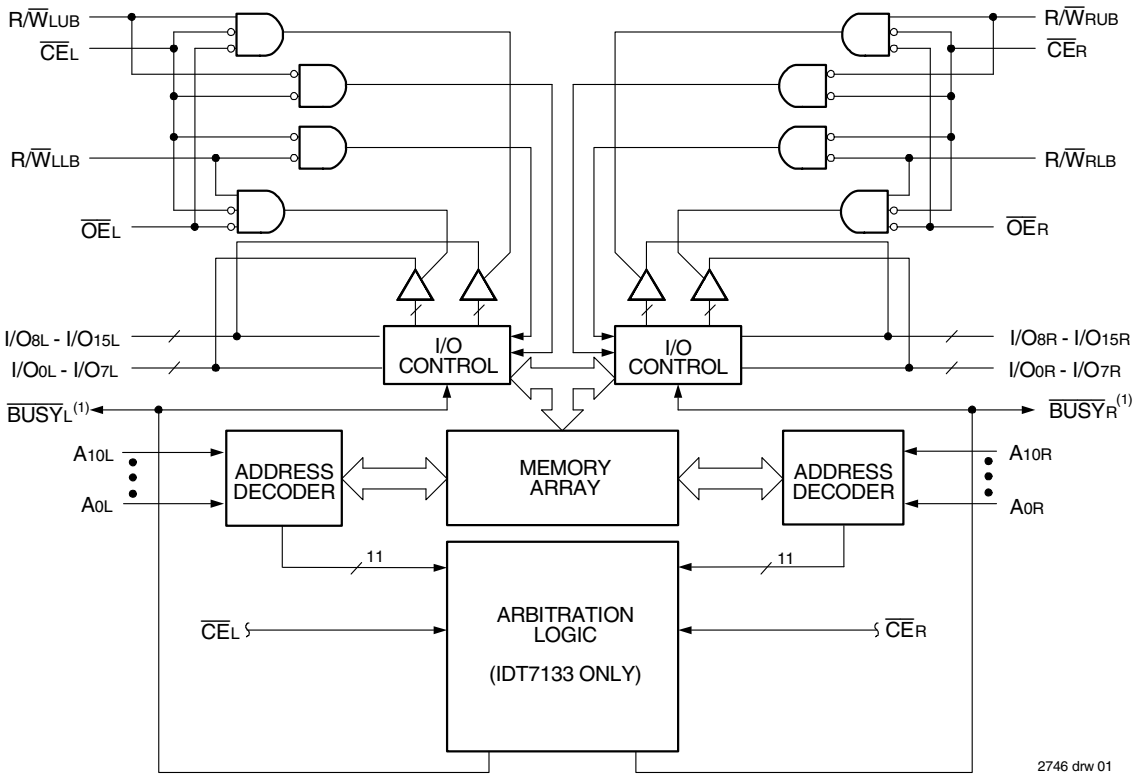
HIGH SPEED 2K X 16 DUAL-PORT SRAM

7133SA/LA
7143SA/LA

Features

- **High-speed access**
  - *Commercial: 20/25/35/45/55/70/90ns (max.)*
  - *Industrial: 25ns (max.)*
  - *Military: 35/55/70/90ns (max.)*
- **Low-power operation**
  - *IDT7133/43SA*
    Active: 1150mW (typ.)
    Standby: 5mW (typ.)
  - *IDT7133/43LA*
    Active: 1050mW (typ.)
    Standby: 1mW (typ.)
- **Versatile control for write: separate write control for lower and upper byte of each port**
- **MASTER IDT7133 easily expands data bus width to 32 bits or more using SLAVE IDT7143**
- **On-chip port arbitration logic (IDT7133 only)**
- **$\overline{BUSY}$ output flag on IDT7133; $\overline{BUSY}$ input on IDT7143**
- **Fully asynchronous operation from either port**
- **Battery backup operation–2V data retention**
- **TTL-compatible; single 5V (±10%) power supply**
- **Available in 68-pin ceramic PGA, Flatpack, PLCC and 100-pin TQFP**
- **Military product compliant to MIL-PRF-38535 QML**
- **Industrial temperature range (–40°C to +85°C) is available for selected speeds**
- **Green parts available, see ordering information**

Functional Block Diagram



NOTE:

1. IDT7133 (MASTER): $\overline{BUSY}$ is open drain output and requires pull-up resistor.
   IDT7143 (SLAVE): $\overline{BUSY}$ is input.

Description

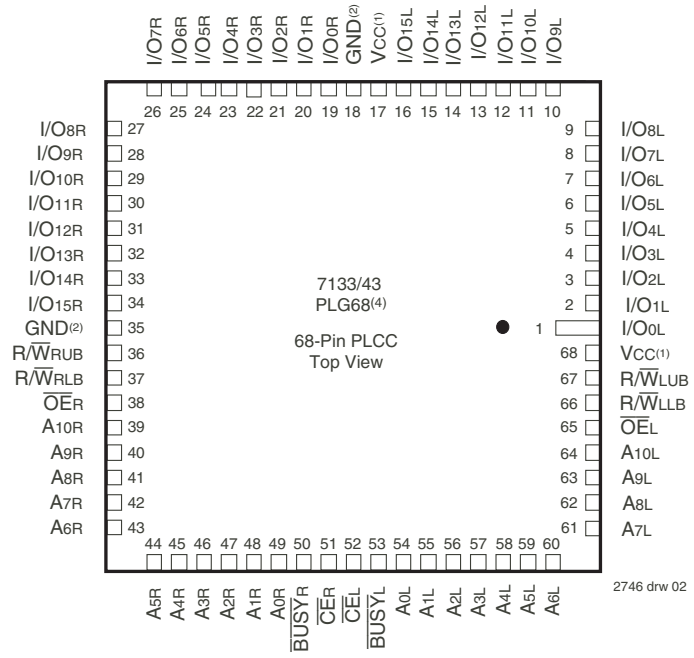
The IDT7133/7143 are high-speed 2K x 16 Dual-Port Static RAMs. The IDT7133 is designed to be used as a stand-alone 16-bit Dual-Port RAM or as a "MASTER" Dual-Port RAM together with the IDT7143 "SLAVE" Dual-Port in 32-bit-or-more word width systems. Using the IDT MASTER/SLAVE Dual-Port RAM approach in 32-bit-or-wider memory system applications results in full-speed, error-free operation without the need for additional discrete logic.

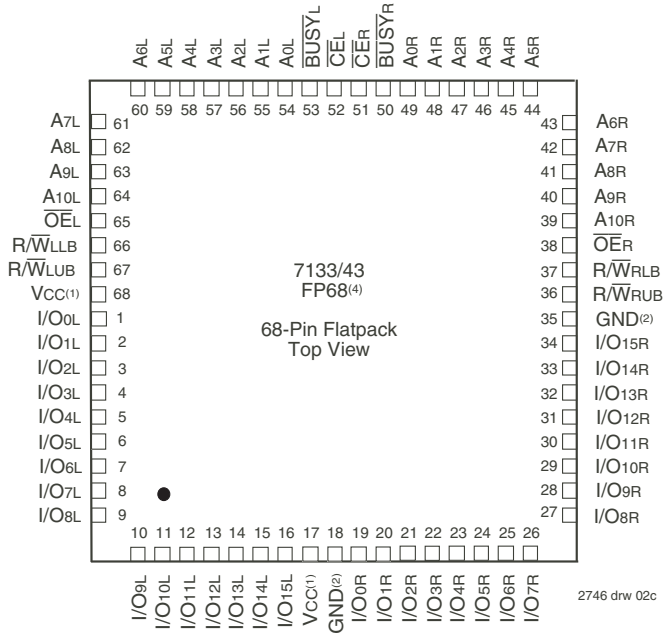
Both devices provide two independent ports with separate control, address, and I/O pins that permit independent, asynchronous access for reads or writes to any location in memory. An automatic power down feature, controlled by $\overline{CE}$, permits the on-chip circuitry of each port to enter a very low standby power mode.

Fabricated using CMOS high-performance technology. Low-power (LA) versions offer battery backup data retention capability, with each port typically consuming 200µW for a 2V battery.

The IDT7133/7143 devices have identical pinouts. Each is packed in a 68-pin ceramic PGA, 68-pin flatpack, 68-pin PLCC and 100-pin TQFP. Military grade product is manufactured in compliance with the latest revision of MIL-PRF-38535 QML, making it ideally suited to military temperature applications demanding the highest level of performance and reliability.

Pin Configurations[1,2,3,4]

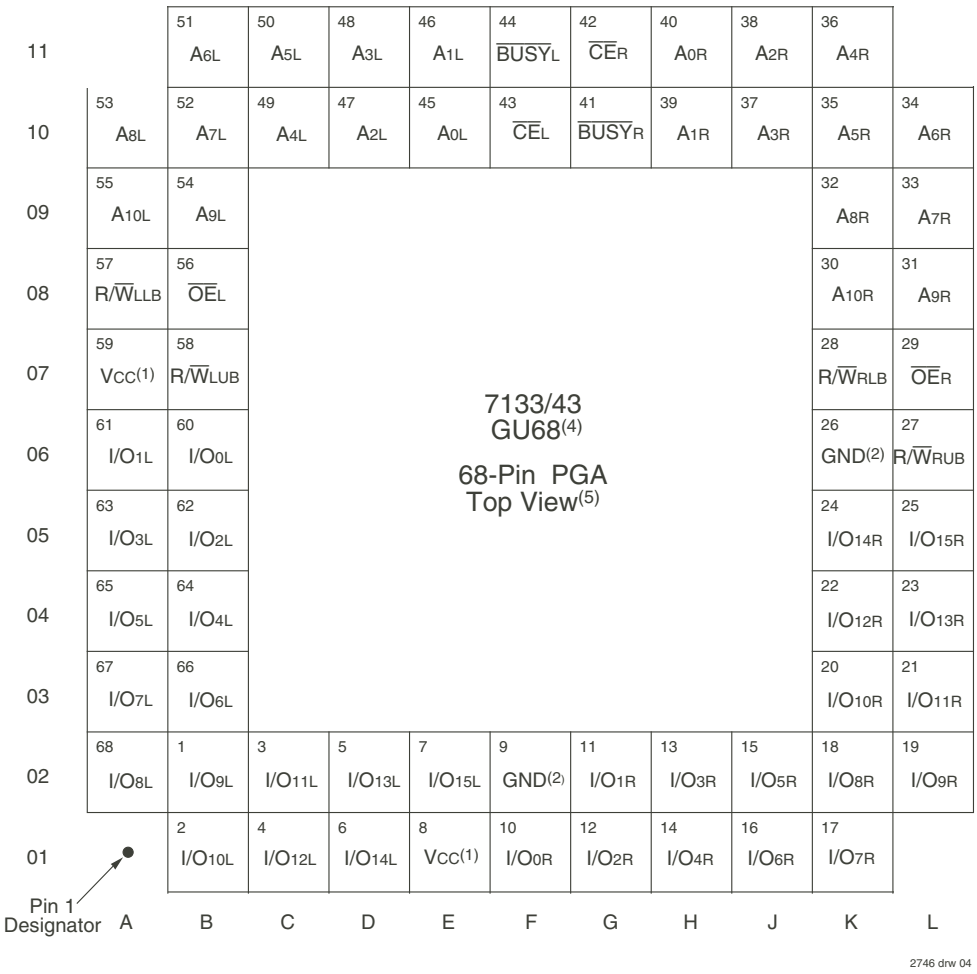




NOTES:

1. Both VCC pins must be connected to the power supply to ensure reliable operation.
2. Both GND pins must be connected to the ground supply to ensure reliable operation.
3. PLG68 package body is approximately 0.95 in x 0.95 in x 0.17 in. FP68 package body is approximately 1.18 in x 1.18 in x 0.16 in.
4. This package code is used to reference the package diagram.

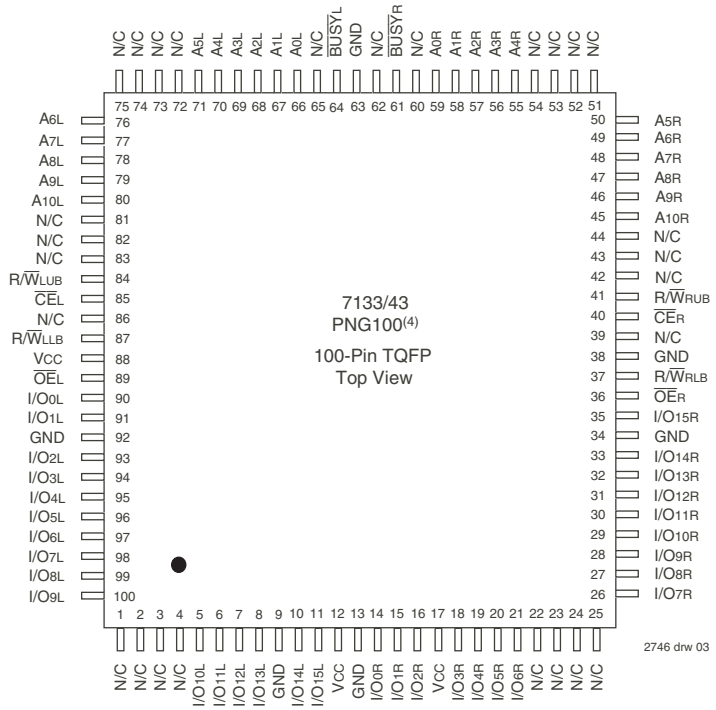
Pin Configurations[1,2,3,4] (con't.)



2746 drw 04

NOTES:
1. Both Vcc pins must be connected to the power supply to ensure reliable operation.
2. Both GND pins must be connected to the ground supply to ensure reliable operation.
3. GU68 package body is approximately 1.18 in x 1.18 in x 0.16 in.
4. This package code is used to reference the package diagram.
5. This text does not indicate orientation of the actual part-marking.

Pin Configurations[1,2,3,4] (con't.)



NOTES:
1. Both VCC pins must be connected to the power supply to ensure reliable operation.
2. Both GND pins must be connected to the ground supply to ensure reliable operation.
3. PNG100 package body is approximately 14mm x 14mm x 1.4mm.
4. This package code is used to reference the package diagram.

Pin Names

Left Port	Right Port	Names
$\overline{CE}_L$	$\overline{CE}_R$	Chip Enable
$R/\overline{W}_{LUB}$	$R/\overline{W}_{RUB}$	Upper Byte Read/Write Enable
$R/\overline{W}_{LLB}$	$R/\overline{W}_{RLB}$	Lower Byte Read/Write Enable
$\overline{OE}_L$	$\overline{OE}_R$	Output Enable
A_{0L} - A_{10L}	A_{0R} - A_{10R}	Address
I/O_{0L} - I/O_{15L}	I/O_{0R} - I/O_{15R}	Data Input/Output
$\overline{BUSY}_L$	$\overline{BUSY}_R$	Busy Flag
V_{CC}		Power
GND		Ground

2746 tbl 01

Absolute Maximum Ratings(1)

Symbol	Rating	Commercial & Industrial	Military	Unit
V_{TERM}(2)	Terminal Voltage with Respect to GND	-0.5 to +7.0	-0.5 to +7.0	V
T_{BIAS}	Temperature Under Bias	-55 to +125	-65 to +135	°C
T_{STG}	Storage Temperature	-65 to +150	-65 to +150	°C
P_T	Power Dissipation	2.0	2.0	W
I_{OUT}	DC Output Current	50	50	mA

2746 tbl 02

NOTES:
1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. V_{TERM} must not exceed Vcc + 10% for more than 25% of the cycle time or 10ns maximum, and is limited to $\leq$ 20mA for the period of $V_{TERM} \geq$ Vcc + 10%.

Maximum Operating Temperature and Supply Voltage(1,2)

Grade	Ambient Temperature	GND	Vcc
Military	-55°C to +125°C	0V	5.0V ± 10%
Commercial	0°C to +70°C	0V	5.0V ± 10%
Industrial	-40°C to +85°C	0V	5.0V ± 10%

2746 tbl 04

NOTES:
1. This is the parameter T_A. This is the "instant on" case temperature.

Recommended DC Operating Conditions

Symbol	Parameter	Min.	Typ.	Max.	Unit
V_{CC}	Supply Voltage	4.5	5.0	5.5	V
GND	Ground	0	0	0	V
V_{IH}	Input High Voltage	2.2	—	6.0(2)	V
V_{IL}	Input Low Voltage	-0.5(1)	—	0.8	V

2746 tbl 05

NOTES:
1. V_{IL} (min.) = -1.5V for pulse width less than 10ns.
2. V_{TERM} must not exceed Vcc + 10%.

Capacitance (T_A = +25°C, f = 1.0mhz)

Symbol	Parameter(1)	Conditions(2)	Max.	Unit
C_{IN}	Input Capacitance	V_{IN} = 3dV	11	pF
C_{OUT}	Output Capacitance	V_{OUT} = 3dV	11	pF

2746 tbl 03

NOTES:
1. This parameter is determined by device characterization but is not production tested.
2. 3dV references the interpolated capacitance when the input and output switch from 0V to 3V or from 3V to 0V.

DC Electrical Characteristics Over the Operating Temperature and Supply Voltage Range (Either port, Vcc = 5.0V ± 10%)

Symbol	Parameter	Test Conditions	7133SA 7143SA		7133LA 7143LA		Unit
			Min.	Max.	Min.	Max.	
$\|I_{LI}\|$	Input Leakage Current(1)	Vcc = 5.5V, V_{IN} = 0V to Vcc	—	10	—	5	µA
$\|I_{LO}\|$	Output Leakage Current	$\overline{CE}$ = V_{IH}, V_{OUT} = 0V to Vcc	—	10	—	5	µA
V_{OL}	Output Low Voltage (I/O_0-I/O_{15})	I_{OL} = 4mA	—	0.4	—	0.4	V
V_{OL}	Open Drain Output Low Voltage ($\overline{BUSY}$)	I_{OL} = 16mA	—	0.5	—	0.5	V
V_{OH}	Output High Voltage	I_{OH} = -4mA	2.4	—	2.4	—	V

2746 tbl 06

NOTE:
1. At Vcc $\leq$ 2.0V, input leakages are undefined.

DC Electrical Characteristics Operating Temperature and Supply Voltage Range[2] (V_{CC} = 5.0V ± 10%)

Symbol	Parameter	Test Condition	Version		7133X20 7143X20 Com'l Only Typ.[1]	7133X20 7143X20 Com'l Only Max.	7133X25 7143X25 Com'l & Ind Typ.[1]	7133X25 7143X25 Com'l & Ind Max.	7133X35 7143X35 Com'l & Military Typ.[1]	7133X35 7143X35 Com'l & Military Max.	Unit
I_{CC}	Dynamic Operating Current (Both Ports Active)	$\overline{CE}$ = V_{IL}, Outputs Disabled f = f_{MAX}[3]	COM'L	S	250	310	250	300	240	295	mA
				L	230	280	230	270	210	250	
			MIL & IND	S	—	—	250	330	240	325	
				L	—	—	230	300	220	295	
I_{SB1}	Standby Current (Both Ports - TTL Level Inputs)	$\overline{CE}_L$ and $\overline{CE}_R$ = V_{IH} f = f_{MAX}[3]	COM'L	S	25	80	25	80	25	70	mA
				L	25	70	25	70	25	60	
			MIL & IND	S	—	—	25	90	25	75	
				L	—	—	25	80	25	65	
I_{SB2}	Standby Current (One Port - TTL Level Inputs)	$\overline{CE}_{"A"}$ = V_{IL} and $\overline{CE}_{"B"}$ = V_{IH}[4] f=f_{MAX}[3] Active Port Outputs Disabled	COM'L	S	140	200	140	200	120	180	mA
				L	120	180	100	170	100	160	
			MIL & IND	S	—	—	140	230	120	200	
				L	—	—	100	190	100	180	
I_{SB3}	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports $\overline{CE}_L$ and $\overline{CE}_R$ > V_{CC} - 0.2V V_{IN} > V_{CC} - 0.2V or V_{IN} < 0.2V, f = 0[4]	COM'L	S	1.0	15	1.0	15	1.0	15	mA
				L	0.2	5	0.2	4	0.2	4	
			MIL & IND	S	—	—	1.0	30	1.0	30	
				L	—	—	0.2	10	0.2	10	
I_{SB4}	Full Standby Current (One Port - CMOS Level Inputs)	$\overline{CE}_{"A"}$ < 0.2V and $\overline{CE}_{"B"}$ > V_{CC} - 0.2V[5] V_{IN} > V_{CC} - 0.2V or V_{IN} < 0.2V Active Port Outputs Disabled f = f_{MAX}[3]	COM'L	S	140	190	140	190	120	170	mA
				L	120	170	120	170	100	150	
			MIL & IND	S	—	—	140	220	120	190	
				L	—	—	120	200	100	170	

2746 tbl 07a

Symbol	Parameter	Test Condition	Version		7133X45 7143X45 Com'l Only Typ.[1]	7133X45 7143X45 Com'l Only Max.	7133X55 7143X55 Com'l, Ind & Military Typ.[1]	7133X55 7143X55 Com'l, Ind & Military Max.	7133X70/90 7143X70/90 Com'l & Military Typ.[1]	7133X70/90 7143X70/90 Com'l & Military Max.	Unit
I_{CC}	Dynamic Operating Current (Both Ports Active)	$\overline{CE}$ = V_{IL}, Outputs Disabled f = f_{MAX}[3]	COM'L	S	230	290	230	285	230	280	mA
				L	210	250	210	250	210	250	
			MIL & IND	S	—	—	230	315	230	310	
				L	—	—	210	285	210	280	
I_{SB1}	Standby Current (Both Ports - TTL Level Inputs)	$\overline{CE}_L$ and $\overline{CE}_R$ = V_{IH} f = f_{MAX}[3]	COM'L	S	25	75	25	70	25	70	mA
				L	25	65	25	60	25	60	
			MIL & IND	S	—	—	25	80	25	75	
				L	—	—	25	70	25	65	
I_{SB2}	Standby Current (One Port - TTL Level Inputs)	$\overline{CE}_{"A"}$ = V_{IL} and $\overline{CE}_{"B"}$ = V_{IH}[4] f=f_{MAX}[3] Active Port Outputs Disabled	COM'L	S	120	190	120	180	120	180	mA
				L	100	170	100	160	100	160	
			MIL & IND	S	—	—	120	210	120	200	
				L	—	—	100	190	100	180	
I_{SB3}	Full Standby Current (Both Ports - CMOS Level Inputs)	Both Ports $\overline{CE}_L$ and $\overline{CE}_R$ > V_{CC} - 0.2V V_{IN} > V_{CC} - 0.2V or V_{IN} < 0.2V, f = 0[4]	COM'L	S	1.0	15	1.0	15	1.0	15	mA
				L	0.2	4	0.2	4	0.2	4	
			MIL & IND	S	—	—	1.0	30	1.0	30	
				L	—	—	0.2	10	0.2	10	
I_{SB4}	Full Standby Current (One Port - CMOS Level Inputs)	$\overline{CE}_{"A"}$ < 0.2V and $\overline{CE}_{"B"}$ > V_{CC} - 0.2V[5] V_{IN} > V_{CC} - 0.2V or V_{IN} < 0.2V Active Port Outputs Disabled f = f_{MAX}[3]	COM'L	S	120	180	120	170	120	170	mA
				L	100	160	100	150	100	150	
			MIL & IND	S	—	—	120	200	120	190	
				L	—	—	100	180	100	170	

2746 tbl 07b

NOTES:

1. V_{CC} = 5V, T_A = +25°C for Typ., and are not production tested. I_{CCDC} = 180mA (typ.)
2. 'X' in part number indicates power rating (SA or LA)
3. At f = f_{MAX}, address and control lines (except Output Enable) are cycling at the maximum frequency read cycle of 1/ t_{RC}, and using "AC Test Conditions" of input levels of GND to 3V.
4. f = 0 means no address or control lines change. Applies only to inputs at CMOS level standby.
5. Port "A" may be either left or right port. Port "B" is the opposite from port "A".

Data Retention Characteristics

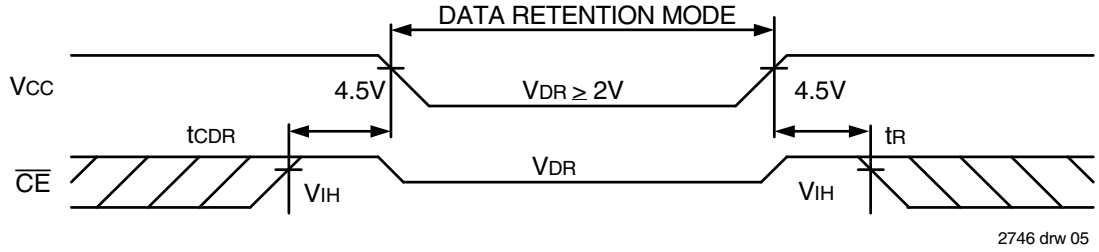
(LA Version Only) V_{LC} = 0.2V, V_{HC} = V_{CC} - 0.2V

Symbol	Parameter	Test Condition		7133LA/7143LA Min.	Typ.(1)	Max.	Unit
V_{DR}	V_{CC} for Data Retention	V_{CC} = 2V		2.0	—	—	V
I_{CCDR}	Data Retention Current	$\overline{CE} \geq V_{HC}$	MIL. & IND.	—	100	4000	µA
		$V_{IN} \geq V_{HC}$ or $\leq V_{LC}$	COM'L.	—	100	1500	
t_{CDR}(3)	Chip Deselect to Data Retention Time			0	—	—	V
t_R(3)	Operation Recovery Time			t_{RC}(2)	—	—	V

2746 tbl 08

NOTES:
1. V_{CC} = 2V, T_A = +25°C, and are not production tested.
2. t_{RC} = Read Cycle Time
3. This parameter is guaranteed by device characterization but is not production tested.

Data Retention Waveform



2746 drw 05

AC Test Conditions

Input Pulse Levels	GND to 3.0V
Input Rise/Fall Times	5ns Max.
Input Timing Reference Levels	1.5V
Output Reference Levels	1.5V
Output Load	Figures 1, 2 and 3

2746 tbl 09

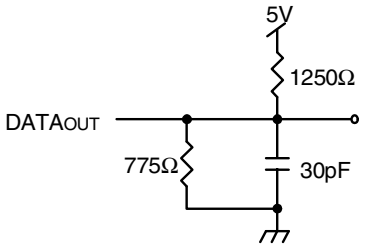


Figure 1. AC Output Test Load

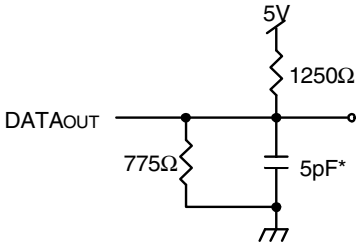
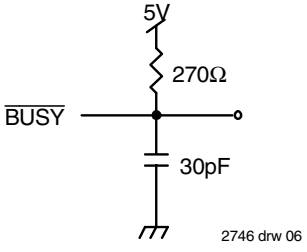


Figure 2. Output Load
(for t_{LZ}, t_{HZ}, t_{WZ}, t_{OW})
*Including scope and jig



2746 drw 06

Figure 3. $\overline{BUSY}$ Output Load
(IDT7133 only)

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage[3]

		7133X20 7143X20 Com'l Only		7133X25 7143X25 Com'l & Ind		7133X35 7143X35 Com'l & Military		
Symbol	**Parameter**	**Min.**	**Max.**	**Min.**	**Max.**	**Min.**	**Max.**	**Unit**
READ CYCLE								
t_{RC}	Read Cycle Time	20	—	25	—	35	—	ns
t_{AA}	Address Access Time	—	20	—	25	—	35	ns
t_{ACE}	Chip Enable Access Time	—	20	—	25	—	35	ns
t_{AOE}	Output Enable Access Time	—	12	—	15	—	20	ns
t_{OH}	Output Hold from Address Change	0	—	0	—	0	—	ns
t_{LZ}	Output Low-Z Time[1,2]	0	—	0	—	0	—	ns
t_{HZ}	Output High-Z Time[1,2]	—	12	—	15	—	20	ns
t_{PU}	Chip Enable to Power Up Time[2]	0	—	0	—	0	—	ns
t_{PD}	Chip Disable to Power Down Time[2]	—	20	—	50	—	50	ns

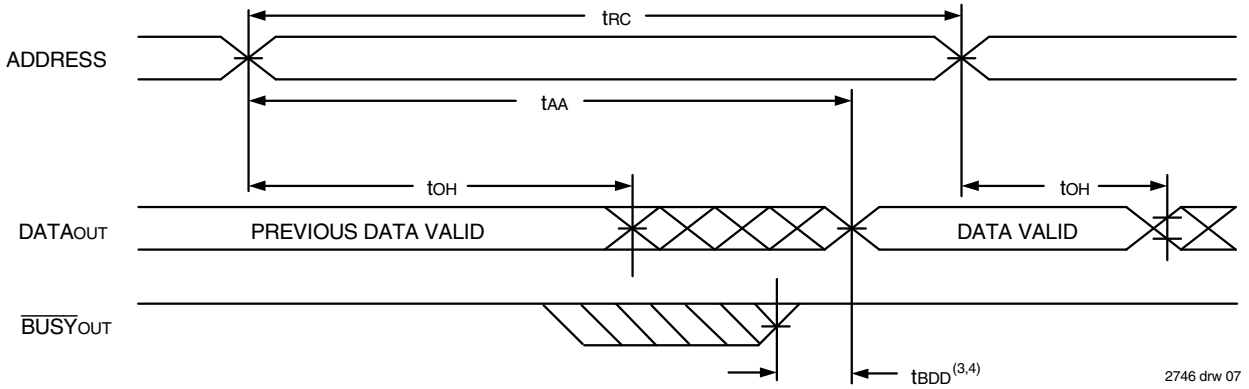
2746 tbl 10a

		7133X45 7143X45 Com'l Only		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military		
Symbol	**Parameter**	**Min.**	**Max.**	**Min.**	**Max.**	**Min.**	**Max.**	**Unit**
READ CYCLE								
t_{RC}	Read Cycle Time	45	—	55	—	70/90	—	ns
t_{AA}	Address Access Time	—	45	—	55	—	70/90	ns
t_{ACE}	Chip Enable Access Time	—	45	—	55	—	70/90	ns
t_{AOE}	Output Enable Access Time	—	25	—	30	—	40/40	ns
t_{OH}	Output Hold from Address Change	0	—	0	—	0/0	—	ns
t_{LZ}	Output Low-Z Time[1,2]	0	—	5	—	5/5	—	ns
t_{HZ}	Output High-Z Time[1,2]	—	20	—	20	—	25/25	ns
t_{PU}	Chip Enable to Power Up Time[2]	0	—	0	—	0/0	—	ns
t_{PD}	Chip Disable to Power Down Time[2]	—	50	—	50	—	50/50	ns

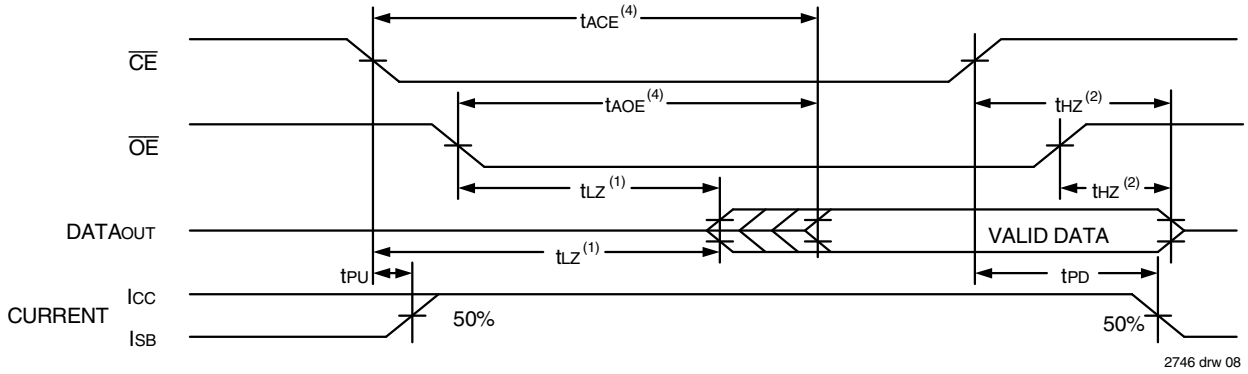
2746 tbl 10b

NOTES:
1. Transition is measured 0mV from Low or High-impedance voltage with load (Figure 2).
2. This parameter is guaranteed by device characterization, but is not production tested.
3. 'X' in part number indicates power rating (SA or LA).

TIMING WAVEFORM OF READ CYCLE NO. 1, EITHER SIDE(5)



TIMING WAVEFORM OF READ CYCLE NO. 2, EITHER SIDE(5)



NOTES:

1. Timing depends on which signal is asserted last, $\overline{OE}$ or $\overline{CE}$.
2. Timing depends on which signal is de-asserted first, $\overline{OE}$ or $\overline{CE}$.
3. t_{BDD} delay is required only in a case where the opposite port is completing a write operation to the same address location. For simultaneous read operations, $\overline{BUSY}$ has no relationship to valid output data.
4. Start of valid data depends on which timing becomes effective last, t_{AOE}, t_{ACE}, t_{AA}, or t_{BDD}.
5. $R/\overline{W}$ = V_{IH}, and the address is valid prior to or coincidental with $\overline{CE}$ transition LOW.

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage[5]

Symbol	Parameter	7133X20 7143X20 Com'l Only		7133X25 7143X25 Com'l & Ind		7133X35 7143X35 Com'l & Military		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
WRITE CYCLE								
t_{WC}	Write Cycle Time[3]	20	—	25	—	35	—	ns
t_{EW}	Chip Enable to End-of-Write	15	—	20	—	25	—	ns
t_{AW}	Address Valid to End-of-Write	15	—	20	—	25	—	ns
t_{AS}	Address Set-up Time	0	—	0	—	0	—	ns
t_{WP}	Write Pulse Width	15	—	20	—	25	—	ns
t_{WR}	Write Recovery Time	0	—	0	—	0	—	ns
t_{DW}	Data Valid to End-of-Write	15	—	15	—	20	—	ns
t_{HZ}	Output High-Z Time[1,2]	—	12	—	15	—	20	ns
t_{DH}	Data Hold Time[4]	0	—	0	—	0	—	ns
t_{WZ}	Write Enable to Output in High-Z[1,2]	—	12	—	15	—	20	ns
t_{OW}	Output Active from End-of-Write[1,2,4]	0	—	0	—	0	—	ns

2746 tbl 11a

Symbol	Parameter	7133X45 7143X45 Com'l Only		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
WRITE CYCLE								
t_{WC}	Write Cycle Time[3]	45	—	55	—	70/90	—	ns
t_{EW}	Chip Enable to End-of-Write	30	—	40	—	50/50	—	ns
t_{AW}	Address Valid to End-of-Write	30	—	40	—	50/50	—	ns
t_{AS}	Address Set-up Time	0	—	0	—	0/0	—	ns
t_{WP}	Write Pulse Width	30	—	40	—	50/50	—	ns
t_{WR}	Write Recovery Time	0	—	0	—	0/0	—	ns
t_{DW}	Data Valid to End-of-Write	20	—	25	—	30/30	—	ns
t_{HZ}	Output High-Z Time[1,2]	—	20	—	20	—	25/25	ns
t_{DH}	Data Hold Time[4]	5	—	5	—	5/5	—	ns
t_{WZ}	Write Enable to Output in High-Z[1,2]	—	20	—	20	—	25/25	ns
t_{OW}	Output Active from End-of-Write[1,2,4]	5	—	5	—	5/5	—	ns

2746 tbl 11b

NOTES:
1. Transition is measured 0mV from Low or High-impedance voltage from the Output Test Load (Figure 2).
2. This parameter is guaranteed by device characterization but not production tested.
3. For MASTER/SLAVE combination, $t_{WC} = t_{BAA} + t_{WR} + t_{WP}$, since $R/\overline{W} = V_{IL}$ must occur after t_{BAA}.
4. The specification for t_{DH} must be met by the device supplying write data to the RAM under all operation conditions. Although t_{DH} and t_{OW} values will vary over voltage and temperature, the actual t_{DH} will always be smaller than the actual t_{OW}.
5. 'X' in part number indicates power rating (SA or LA).

AC Electrical Characteristics Over the Operating Temperature and Supply Voltage(6)

Symbol	Parameter	7133X20 7143X20 Com'l Only		7133X25 7143X25 Com'l & Ind		7133X35 7143X35 Com'l & Military		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
$\overline{BUSY}$ TIMING (For MASTER 71V33)								
t_{BAA}	$\overline{BUSY}$ Access Time from Address	—	20	—	20	—	30	ns
t_{BDA}	$\overline{BUSY}$ Disable Time from Address	—	20	—	20	—	30	ns
t_{BAC}	$\overline{BUSY}$ Access Time from Chip Enable	—	20	—	20	—	25	ns
t_{BDC}	$\overline{BUSY}$ Disable Time from Chip Enable	—	17	—	20	—	25	ns
t_{WDD}	Write Pulse to Data Delay(1)	—	40	—	50	—	60	ns
t_{DDD}	Write Data Valid to Read Data Delay(1)	—	30	—	35	—	45	ns
t_{BDD}	$\overline{BUSY}$ Disable to Valid Data(2)	—	25	—	30	—	35	ns
t_{APS}	Arbitration Priority Set-up Time(3)	5	—	5	—	5	—	ns
t_{WH}	Write Hold After $\overline{BUSY}$(5)	20	—	20	—	25	—	ns
$\overline{BUSY}$ INPUT TIMING (For SLAVE 71V43)								
t_{WB}	$\overline{BUSY}$ Input to Write(4)	0	—	0	—	0	—	ns
t_{WH}	Write Hold After $\overline{BUSY}$(5)	20	—	20	—	25	—	ns
t_{WDD}	Write Pulse to Data Delay(1)	—	40	—	50	—	60	ns
t_{DDD}	Write Data Valid to Read Data Delay(1)	—	30	—	35	—	45	ns

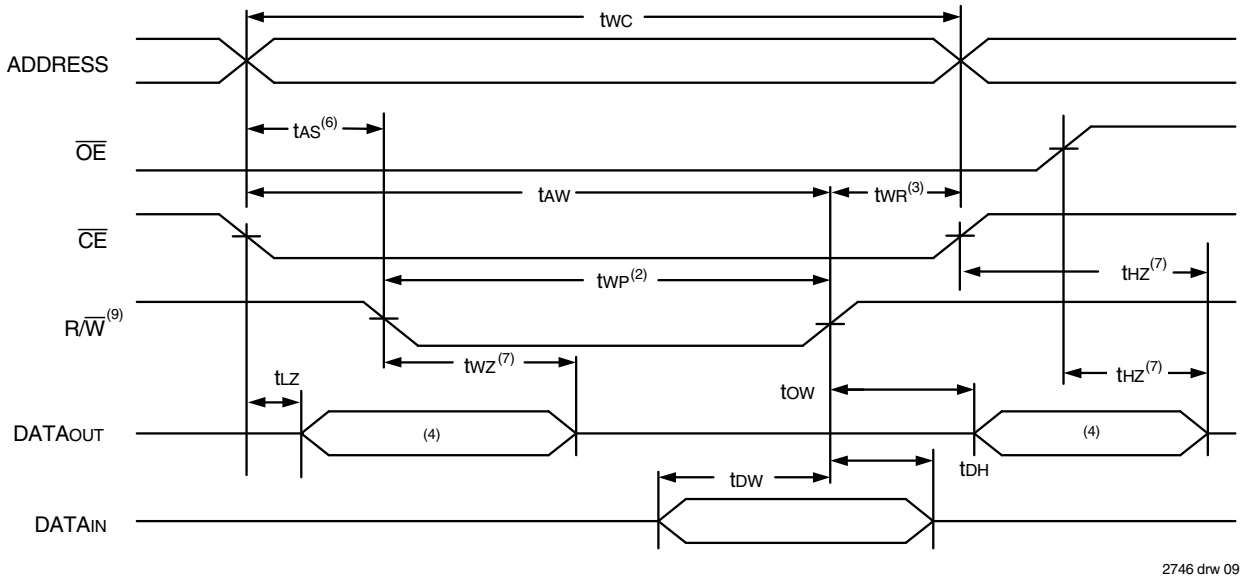
2746 tbl 12a

Symbol	Parameter	7133X45 7143X45 Com'l Only		7133X55 7143X55 Com'l, Ind & Military		7133X70/90 7143X70/90 Com'l & Military		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	
$\overline{BUSY}$ TIMING (For MASTER 71V33)								
t_{BAA}	$\overline{BUSY}$ Access Time from Address	—	40	—	40	—	45/45	ns
t_{BDA}	$\overline{BUSY}$ Disable Time from Address	—	40	—	40	—	45/45	ns
t_{BAC}	$\overline{BUSY}$ Access Time from Chip Enable	—	30	—	35	—	35/35	ns
t_{BDC}	$\overline{BUSY}$ Disable Time from Chip Enable	—	25	—	30	—	30/30	ns
t_{WDD}	Write Pulse to Data Delay(1)	—	80	—	80	—	90/90	ns
t_{DDD}	Write Data Valid to Read Data Delay(1)	—	55	—	55	—	70/70	ns
t_{BDD}	$\overline{BUSY}$ Disable to Valid Data(2)	—	40	—	40	—	40/40	ns
t_{APS}	Arbitration Priority Set-up Time(3)	5	—	5	—	5/5	—	ns
t_{WH}	Write Hold After $\overline{BUSY}$(5)	30	—	30	—	30/30	—	ns
$\overline{BUSY}$ INPUT TIMING (For SLAVE 71V43)								
t_{WB}	$\overline{BUSY}$ Input to Write(4)	0	—	0	—	0/0	—	ns
t_{WH}	Write Hold After $\overline{BUSY}$(5)	30	—	30	—	30/30	—	ns
t_{WDD}	Write Pulse to Data Delay(1)	—	80	—	80	—	90/90	ns
t_{DDD}	Write Data Valid to Read Data Delay(1)	—	55	—	55	—	70/70	ns

2746 tbl 12b

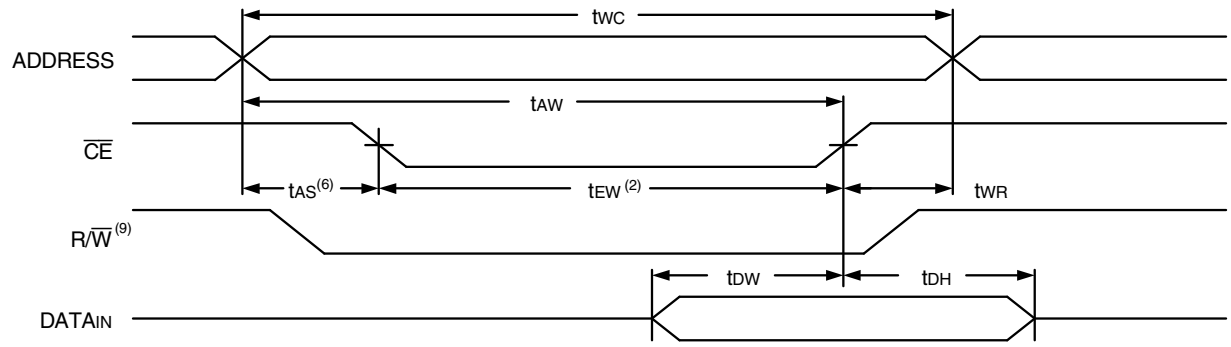
NOTES:
1. Port-to-port delay through RAM cells from writing port to reading port, refer to "Timing Waveform of Write with Port-to-Port Read and Busy".
2. t_{BDD} is calculated parameter and is greater of 0, t_{WDD} - t_{WP} (actual) or t_{DDD} - t_{DW} (actual).
3. To ensure that the earlier of the two ports wins.
4. To ensure that the write cycle is inhibited on port "B" during contention on port "A".
5. To ensure that a write cycle is completed on port "B" after contention on port "A".
6. 'X' in part number indicates power rating (SA or LA).

Timing Waveform of Write Cycle No. 1 (R/$\overline{W}$ Controlled Timing)(1,5,8)



2746 drw 09

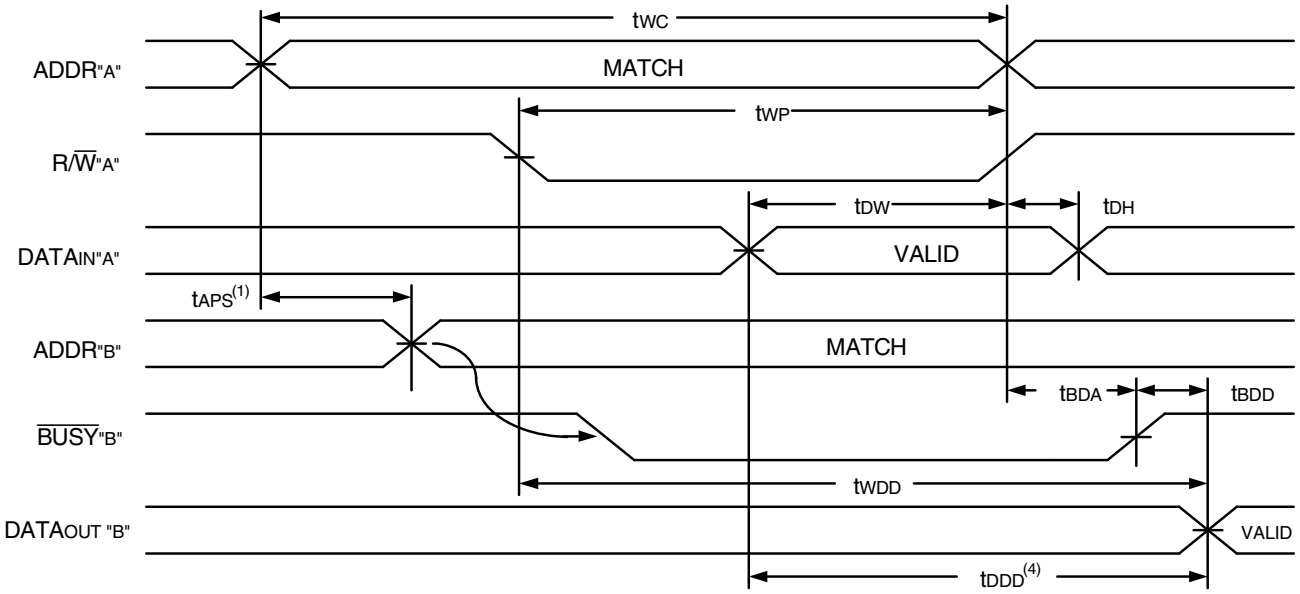
Write Cycle No. 2 ($\overline{CE}$ Controlled Timing)(1,5)



2746 drw 10

NOTES:
1. R/$\overline{W}$ or $\overline{CE}$ must be HIGH during all address transitions.
2. A write occurs during the overlap (t_{EW} or t_{WP}) of a $\overline{CE}$ = V_{IL} and a R/$\overline{W}$ = V_{IL}.
3. t_{WR} is measured from the earlier of $\overline{CE}$ or R/$\overline{W}$ going HIGH to the end of the write cycle.
4. During this period, the I/O pins are in the output state, and input signals must not be applied.
5. If the $\overline{CE}$ LOW transition occurs simultaneously with or after the R/$\overline{W}$ LOW transition, the outputs remain in the High-impedance state.
6. Timing depends on which enable signal ($\overline{CE}$ or R/$\overline{W}$) is asserted last.
7. Timing depends on which enable signal is de-asserted first, $\overline{CE}$ or $\overline{OE}$.
8. If $\overline{OE}$ is LOW during a R/$\overline{W}$ controlled write cycle, the write pulse width must be the larger of t_{WP} or (t_{WZ} + t_{DW}) to allow the I/O drivers to turn off and data to be placed on the bus for the required t_{DW}. If $\overline{OE}$ is HIGH during an R/$\overline{W}$ controlled write cycle, this requirement does not apply and the write pulse can be as short as the specified t_{WP}.
9. R/$\overline{W}$ for either upper or lower byte.

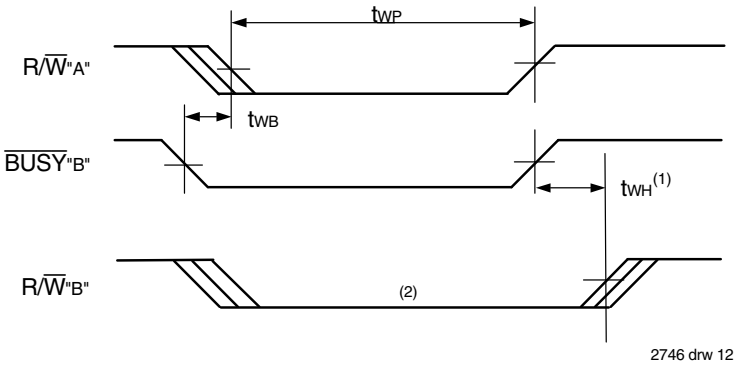
Timing Waveform of Write with Port-to-Port Read and $\overline{BUSY}$ (1,2,3)



2746 drw 11

NOTES:
1. To ensure that the earlier of the two ports wins, t_{APS} is ignored for Slave (IDT7143).
2. $\overline{CE}_L = \overline{CE}_R = V_{IL}$
3. $\overline{OE} = V_{IL}$ for the reading port.
4. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".

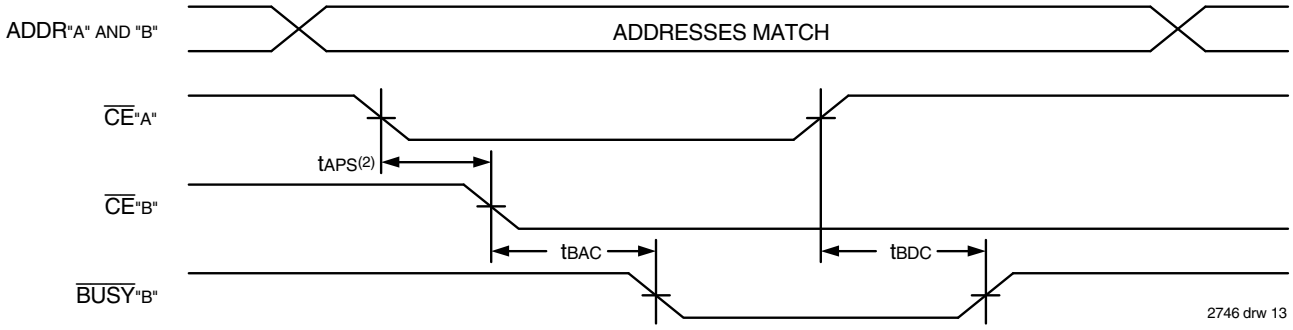
Timing Waveform of Write with $\overline{BUSY}$ (3)



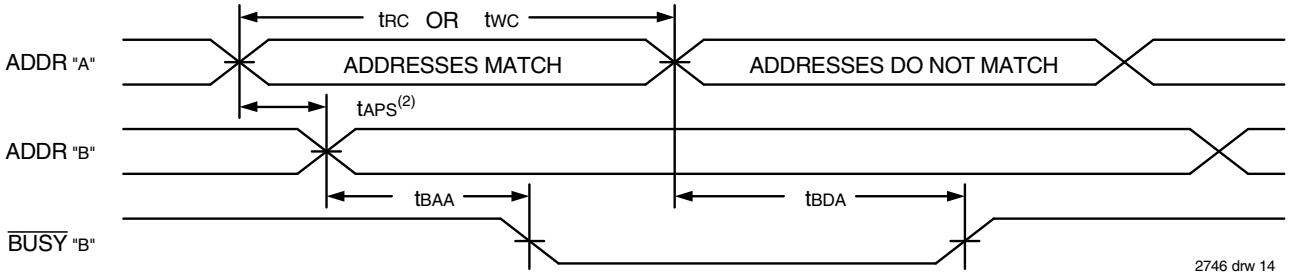
2746 drw 12

NOTES:
1. t_{WH} must be met for both $\overline{BUSY}$ input (IDT7143, slave) and output (IDT7133, master).
2. $\overline{BUSY}$ is asserted on port "B" blocking $R/\overline{W}$"B", until $\overline{BUSY}$"B" goes HIGH.
3. All timing is the same for left and right ports. Port "A" may be either left or right port. Port "B" is the opposite from port "A".

Timing Waveform of $\overline{\text{BUSY}}$ Arbitration Controlled by $\overline{\text{CE}}$ Timing(1)



Timing Waveform of $\overline{\text{BUSY}}$ Arbitration Controlled by Addresses(1)



NOTES:

1. All timing is the same for left and right ports. Port "A" may be either the left or right port. Port "B" is the port opposite from port "A".
2. If t_{APS} is not satisfied, the $\overline{\text{BUSY}}$ will be asserted on one side or the other, but there is no guarantee on which side $\overline{\text{BUSY}}$ will be asserted (IDT7133 only).

Functional Description

The IDT7133/43 provides two ports with separate control, address and I/O pins that permit independent access for reads or writes to any location in memory. The IDT7133/43 has an automatic power down feature controlled by $\overline{CE}$. The $\overline{CE}$ controls on-chip power down circuitry that permits the respective port to go into a standby mode when not selected ($\overline{CE}$ HIGH). When a port is enabled, access to the entire memory array is permitted. Non-contention READ/WRITE conditions are illustrated in Truth Table 1.

Busy Logic

Busy Logic provides a hardware indication that both ports of the RAM have accessed the same location at the same time. It also allows one of the two accesses to proceed and signals the other side that the RAM is "busy". The $\overline{BUSY}$ pin can then be used to stall the access until the operation on the other side is completed. If a write operation has been attempted from the side that receives a $\overline{BUSY}$ indication, the write signal is gated internally to prevent the write from proceeding.

The use of $\overline{BUSY}$ logic is not required or desirable for all applications. In some cases it may be useful to logically OR the $\overline{BUSY}$ outputs together and use any $\overline{BUSY}$ indication as an interrupt source to flag the event of an illegal or illogical operation. If the write inhibit function of BUSY logic is not desirable, the $\overline{BUSY}$ logic can be disabled by using the IDT7143 (SLAVE). In the IDT7143, the $\overline{BUSY}$ pin operates solely as a write inhibit input pin. Normal operation can be programmed by tying the $\overline{BUSY}$ pins HIGH. If desired, unintended write operations can be prevented to a port by tying the $\overline{BUSY}$ pin for that port LOW. The $\overline{BUSY}$ outputs on the IDT 7133 RAM are open drain and require pull-up resistors.

Width Expansion with Busy Logic Master/Slave Arrays

When expanding an IDT7133/43 RAM array in width while using $\overline{BUSY}$ logic, one master part is used to decide which side of the RAM array will receive a $\overline{BUSY}$ indication, and to output that indication. Any number of slaves to be addressed in the same address range as the master, use the $\overline{BUSY}$ signal as a write inhibit signal. Thus on the IDT7133 RAM the $\overline{BUSY}$ pin is an output and on the IDT7143 RAM, the $\overline{BUSY}$ pin is an input (see Figure 3).

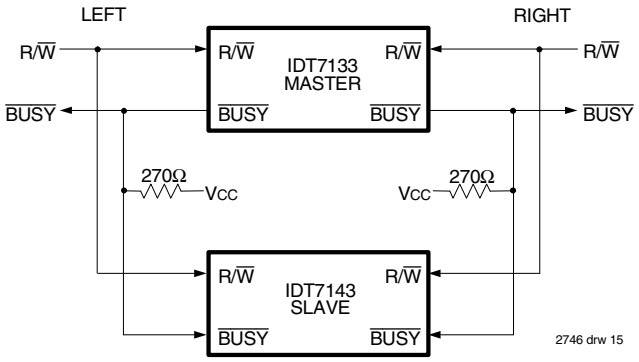


Figure 4. Busy and chip enable routing for both width and depth expansion with the IDT7133 (MASTER) and the IDT7143 (SLAVE).

Expanding the data bus width to 32 bits or more in a Dual-Port RAM system implies that several chips will be active at the same time. If each chip includes a hardware arbitrator, and the addresses for each chip arrive at the same time, it is possible that one will activate its $\overline{BUSY}_L$ while another activates its $\overline{BUSY}_R$ signal. Both sides are now $\overline{BUSY}$ and the CPUs will await indefinitely for their port to become free.

To avoid the "Busy Lock-Out" problem, IDT has developed a MASTER/SLAVE approach where only one hardware arbitrator, in the MASTER, is used. The SLAVE has $\overline{BUSY}$ inputs which allow an interface to the MASTER with no external components and with a speed advantage over other systems.

When expanding Dual-Port RAMs in width, the writing of the SLAVE RAMs must be delayed until after the $\overline{BUSY}$ input has settled. Otherwise, the SLAVE chip may begin a write cycle during a contention situation. Conversely, the write pulse must extend a hold time past $\overline{BUSY}$ to ensure that a write cycle takes place after the contention is resolved. This timing is inherent in all Dual-Port memory systems where more than one chip is active at the same time.

The write pulse to the SLAVE should be delayed by the maximum arbitration time of the MASTER. If, then, a contention occurs, the write to the SLAVE will be inhibited due to $\overline{BUSY}$ from the MASTER.

Truth Table I – Non-Contention Read/Write Control(4)

LEFT OR RIGHT PORT(1)						Function
$R/\overline{W}_{LB}$	$R/\overline{W}_{UB}$	$\overline{CE}$	$\overline{OE}$	I/O_{0-7}	I/O_{8-15}	
X	X	H	X	Z	Z	Port Disabled and in Power Down Mode, I_{SB2}, I_{SB4}
X	X	H	X	Z	Z	$CE_R = CE_L = V_{IH}$, Power Down Mode, I_{SB1} or I_{SB3}
L	L	L	X	$DATA_{IN}$	$DATA_{IN}$	Data on Lower Byte and Upper Byte Written into Memory(2)
L	H	L	L	$DATA_{IN}$	$DATA_{OUT}$	Data on Lower Byte Written into Memory(2), Data in Memory Output on Upper Byte(3)
H	L	L	L	$DATA_{OUT}$	$DATA_{IN}$	Data in Memory Output on Lower Byte(3), Data on Upper Byte Written into Memory(2)
L	H	L	H	$DATA_{IN}$	Z	Data on Lower Byte Written into Memory(2)
H	L	L	H	Z	$DATA_{IN}$	Data on Upper Byte Written into Memory(2)
H	H	L	L	$DATA_{OUT}$	$DATA_{OUT}$	Data in Memory Output on Lower Byte and Upper Byte
H	H	L	H	Z	Z	High Impedance Outputs

2746 tbl 13

NOTES:
1. A_{0L} - $A_{10L} \neq A_{0R}$ - A_{10R}
2. If $\overline{BUSY}$ = LOW, data is not written.
3. If $\overline{BUSY}$ = LOW, data may not be valid, see t_{WDD} and t_{DDD} timing.
4. "H" = HIGH, "L" = LOW, "X" = Don't Care, "Z" = High-Impedance, "LB" = Lower Byte, "UB" = Upper Byte

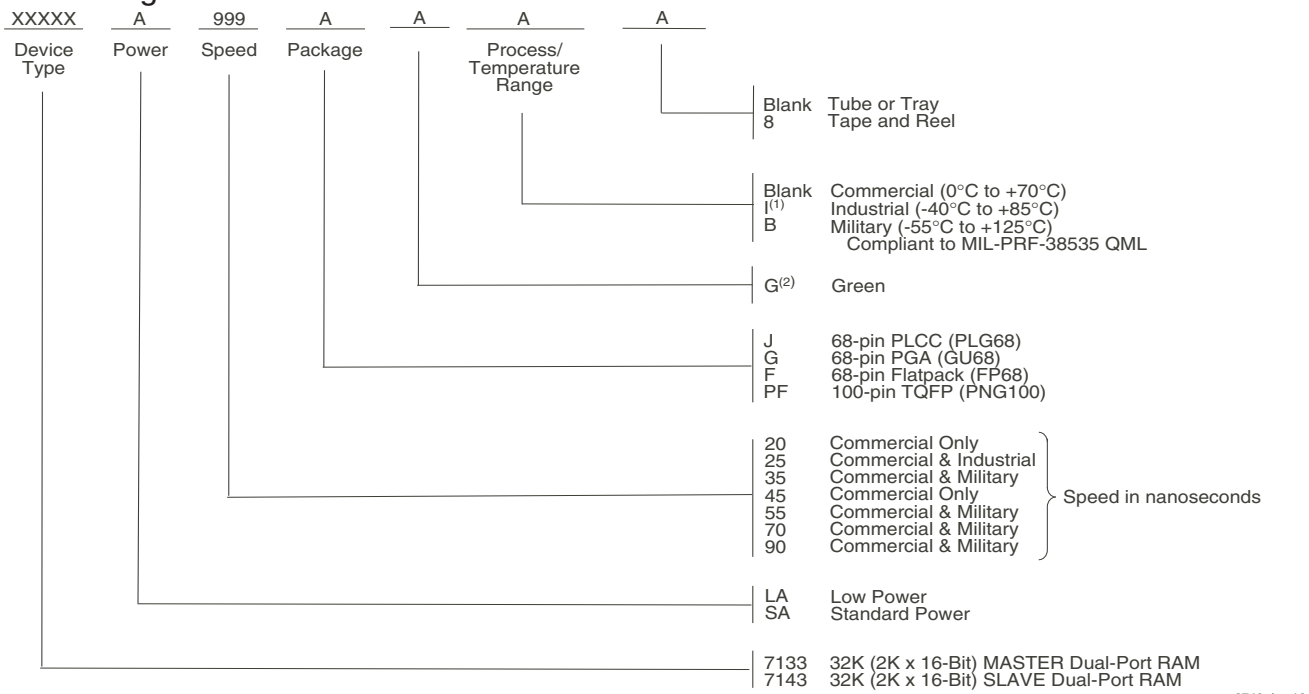
Truth Table II — Address $\overline{BUSY}$ Arbitration

Inputs			Outputs		
$\overline{CE}_L$	$\overline{CE}_R$	A_{0L}-A_{10L} A_{0R}-A_{10R}	$\overline{BUSY}_L$(1)	$\overline{BUSY}_R$(1)	Function
X	X	NO MATCH	H	H	Normal
H	X	MATCH	H	H	Normal
X	H	MATCH	H	H	Normal
L	L	MATCH	(2)	(2)	Write Inhibit(3)

2746 tbl 14

NOTES:
1. Pins $\overline{BUSY}_L$ and $\overline{BUSY}_R$ are both outputs on the IDT7133 (MASTER). Both are inputs on the IDT7143 (SLAVE). On Slaves the $\overline{BUSY}$ input internally inhibits writes.
2. "L" if the inputs to the opposite port were stable prior to the address and enable inputs of this port. "H" if the inputs to the opposite port became stable after the address and enable inputs of this port. If t_{APS} is not met, either $\overline{BUSY}_L$ or $\overline{BUSY}_R$ = V_{IL} will result $\overline{BUSY}_L$ and $\overline{BUSY}_R$ outputs can not be LOW simultaneously.
3. Writes to the left port are internally ignored when $\overline{BUSY}_L$ outputs are driving LOW regardless of actual logic level on the pin. Writes to the right port are internally ignored when $\overline{BUSY}_R$ outputs are driving LOW regardless of actual logic level on the pin.

Ordering Information



2746 drw 16

NOTES:

1. Contact your local sales office for industrial temp. range for other speeds, packages and powers.
2. Green parts available. For specific speeds, packages and powers contact your local sales office.
   LEAD FINISH (SnPb) parts are Obsolete excluding PGA and Flatpack. Product Discontinuation Notice - PDN# SP-17-02
   Note that information regarding recently obsoleted parts are included in this datasheet for customer convenience.

Orderable Part Information

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7133LA20G	GU68	PGA	C
	7133LA20JG	PLG68	PLCC	C
	7133LA20JG8	PLG68	PLCC	C
	7133LA20PFG	PNG100	TQFP	C
	7133LA20PFG8	PNG100	TQFP	C
25	7133LA25G	GU68	PGA	C
	7133LA25JGI	PLG68	PLCC	I
	7133LA25JGI8	PLG68	PLCC	I
	7133LA25PFGI	PNG100	TQFP	I
	7133LA25PFGI8	PNG100	TQFP	I
35	7133LA35FB	FP68	FPACK	M
	7133LA35G	GU68	PGA	C
	7133LA35GB	GU68	PGA	M
45	7133LA45G	GU68	PGA	C
55	7133LA55FB	FP68	FPACK	M
	7133LA55G	GU68	PGA	C
	7133LA55GB	GU68	PGA	M
70	7133LA70G	GU68	PGA	C
	7133LA70GB	GU68	PGA	M
90	7133LA90G	GU68	PGA	C
	7133LA90GB	GU68	PGA	M

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7133SA20G	GU68	PGA	C
25	7133SA25G	GU68	PGA	C
35	7133SA35FB	FP68	FPACK	M
	7133SA35G	GU68	PGA	C
	7133SA35GB	GU68	PGA	M
	7133SA35PFG	PNG100	TQFP	C
	7133SA35PFG8	PNG100	TQFP	C
45	7133SA45G	GU68	PGA	C
55	7133SA55FB	FP68	FPACK	M
	7133SA55G	GU68	PGA	C
	7133SA55GB	GU68	PGA	M
70	7133SA70G	GU68	PGA	C
	7133SA70GB	GU68	PGA	M
90	7133SA90G	GU68	PGA	C
	7133SA90GB	GU68	PGA	M

Orderable Part Information (con't)

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7143LA20G	GU68	PGA	C
	7143LA20JG	PLG68	PLCC	C
	7143LA20JG8	PLG68	PLCC	C
25	7143LA25G	GU68	PGA	C
35	7143LA35FB	FP68	FPACK	M
	7143LA35G	GU68	PGA	C
	7143LA35GB	GU68	PGA	M
55	7143LA55G	GU68	PGA	C
	7143LA55GB	GU68	PGA	M
70	7143LA70GB	GU68	PGA	M
90	7143LA90GB	GU68	PGA	M

Speed (ns)	Orderable Part ID	Pkg. Code	Pkg. Type	Temp. Grade
20	7143SA20G	GU68	PGA	C
25	7143SA25G	GU68	PGA	C
35	7143SA35FB	FP68	FPACK	M
	7143SA35G	GU68	PGA	C
	7143SA35GB	GU68	PGA	M
55	7143SA55G	GU68	PGA	C
	7143SA55GB	GU68	PGA	M
70	7143SA70GB	GU68	PGA	M
90	7143SA90GB	GU68	PGA	M

Datasheet Document History

12/18/98:		Initiated datasheet document history
		Converted to new format
		Cosmetic and typographical corrections
		Added additional notes to pin configurations
	Page 2	Corrected PN100 pinout
02/17/99:		Corrected PF ordering code
030/9/99:		Cosmetic and typographical corrections
06/09/99:		Changed drawing format
10/01/99:		Added Industrial Temperature Ranges and removed corresponding notes
11/10/99:		Replaced IDT logo
04/01/00:		Changed ±500mV to 0mV in notes
	Page 2	Fixed overbar in pinout
06/26/00:	Page 4	Increased storage temperature parameters
		Clarified T_A parameter
	Page 5	DC Electrical parameters–changed wording from "open" to "disabled"
01/31/06:	Page 1	Added green availability to features
	Page 16	Added green indicator for ordering information
10/21/08:	Page 16	Removed "IDT" from orderable part number
01/16/13:	Page 1, 5, 7, 9 &10	Removed Military 25ns & 45ns & Industrial 35ns speed grades from Features and from the headers of the MIL & IND of the DC Chars and AC Chars tables to indicate this change
	Page 5	Removed the Typ & Max values for the MIL & IND temp range from the 7133x45 and 7143x45 speed grade offering from the DC Chars tables to indicate this change, see table 07b
	Page 4	Removed annotation for footnote 3 in the Absolute Maximum Ratings table
	Page 8 & 9	Typo/correction
	Page 16	Added T& R indicator to and removed Military 25ns & 45ns & Industrial 35ns speed grades from the ordering information
		Product Discontinuation Notice - PDN# SP-17-02
		Last time buy expires June 15, 2018
08/13/19:		Page 1 & 16 Deleted obsolete Industrial speed 55ns
		Page 2 Rotated PLG68 PLCC and PNG100 TQFP pin configurations to accurately reflect pin 1 orientation
		Page 16 Added Orderable Part Information
06/16/21:		Pages 1-19 Rebranded as Renesas datasheet
		Page 2 Rotated FP68 Flatpack pin configuration to accurately reflect pin 1 orientation

IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES (“RENESAS”) PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES “AS IS” AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers skilled in the art designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only for development of an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising out of your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use of any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Rev.1.0 Mar 2020)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu,
Koto-ku, Tokyo 135-0061, Japan
www.renesas.com

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit:
www.renesas.com/contact/

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for SRAM ***category:***

Click to view products by Renesas ***manufacturer:***

Other Similar products are found below :

CY6116A-35DMB CY7C1049GN-10VXI GS8161Z36DD-200I GS88237CB-200I RMLV0408EGSB-4S2#AA0 IDT70V5388S166BG IS64WV3216BLL-15CTLA3 IS66WVE4M16ECLL-70BLI PCF8570P K6F2008V2E-LF70000 K6T4008C1B-GB70 CY7C1353S-100AXC AS6C8016-55BIN AS7C164A-15PCN 515712X IDT71V67603S133BG IS62WV51216EBLL-45BLI IS63WV1288DBLL-10HLI IS66WVE2M16ECLL-70BLI IS66WVE4M16EALL-70BLI IS61WV102416DBLL-10TLI CY7C1381KV33-100AXC CY7C1381KVE33-133AXI 8602501XA 5962-3829425MUA 5962-3829430MUA 5962-8866201YA 5962-8866204TA 5962-9062007MXA 5962-9161705MXA GS882Z18CD-150I 8413202RA 5962-8866208YA 5962-8866203YA IS61WV102416DBLL-10BLI IS66WVC2M16ECLL-7010BLI CY7C1380KV33-250AXC AS6C8016-55BINTR GS81284Z18B-250I AS7C34096B-10TIN GS84018CB-200I IS62WV25616EALL-55TLI IS61WV204816BLL-10TLI GS8128418B-167IV CY7C1460KV25-200BZXI CY7C1315KV18-333BZXC CY62157G30-45ZSXI 71V016SA12YG RMLV0416EGBG-4S2#AC0 CY62126EV18LL-70BVXI